

<b>Notice of References Cited</b>	Application/Control No. 10/728,765	Applicant(s)/Patent Under Reexamination KIM, TAE YUN	
	Examiner Tan T. Nguyen	Art Unit 2827	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,933,907	06-1990	Kumanoya et al.	365/222
*	B	US-5,270,982	12-1993	Watanabe, Hiroshi	365/222
*	C	US-2004/0093461	05-2004	Kim, Tae Yun	711/106
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 2003091989 A	03-2003	Japan	LEE, JAE YOUL	G11C 11/406
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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